Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination		
10/520,301	WUENSCH, STEFFEN		
Examiner	Art Unit		
Brian Nash	3721		

SEARCHED						
Class	Subclass	Date	Examiner			
173	179,168, 171,75, 217	3/5/2007	BN			
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INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	

SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
·	DATE	EXMR		
173 and text, IDS, invntr srch via EAST	3/5/2007	BN		
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